GSM3368ASF

30V N-Channel Enhancement Mode MOSFET

Product Description

The N-Channel enhancement mode power field effect transistor is using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

The device is well suited for high efficiency fast switching applications.

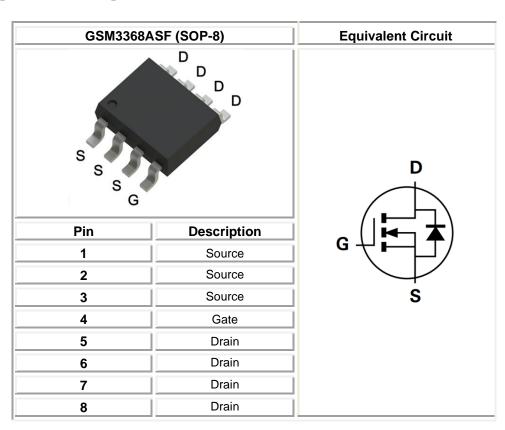
Features

- $R_{DS(ON)} = 6m\Omega$ @ $V_{GS} = 10V$
- $R_{DS(ON)} = 9.8 \text{m}\Omega$ @ $V_{GS} = 4.5 \text{V}$
- SOP-8 Package

Applications

- MB / VGA / Vcore
- POL
- SMPS

Packages & Pin Assignments





Ordering and Marking Information

Ordering Information				
Part Number	Package	Part Marking	Quantity / Reel	
GSM3368ASF	SOP-8	SOP-8 3368ASF		
GSM3368A 1 2				
- Product Code: GSM3368A			Level: or RoHS Compliant Halogen Free	
	Marking Ir	nformation		
- Product Code: 3368ASF - GS Code:				

Absolute Maximum Ratings

T_A=25°C, unless otherwise specified

Symbol	Parameter	Value	Unit		
V _{DSS}	Drain-Source Voltage		30	V	
V _{GSS}	Gate-Source Voltage		±20	V	
	Continuous Drain Current ¹	T _A =25°C	13	А	
lo		T _A =70°C	10		
I _{DM}	Pulsed Drain Current ²	65	Α		
	Total Davier Dissipation 3	T _A =25°C	1.5	10/	
P _D To	Total Power Dissipation ³	T _A =70°C	1	W	
TJ	Operating Junction Temperature Range	-55 to +150	°C		
Tstg	Storage Temperature Range	-55 to +150	°C		
ReJA	Thermal Resistance, Junction to Ambient ¹	80	°C/W		

- Note: 1.The data tested by surface mounted on a 1 inch2 FR-4 board with 2oz copper. 2.The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%. 3.The power dissipation is limited by 150°C junction temperature.



Electrical Characteristics

TA=25°C, unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
	Statio	characteristics				
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	30	-	-	V
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	1.2	-	2.5	V
Igss	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
IDSS	Drain-Source Leakage Current	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
Б	Dunin Course On Boninton	V _{GS} =10V, I _D =15A	-	4.2	6	
R _{DS(ON)}	Drain-Source On-Resistance	V _{GS} =4.5V, I _D =10A	-	5.6	9.8	mΩ
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =20A	-	-	1.2	V
	Dynamic characteristics					
Ciss	Input Capacitance		-	2295	-	
Coss	Output Capacitance Vps=15V, Ves=0V, f=1MHz		-	267	-	pF
Crss	Reverse Transfer Capacitance	-	-	210	-	
Rg	Gate Resistance	V _{DS} =0V, V _{GS} =0V, f=1MHz	-	1.7	-	Ω
Q_g	Total Gate Charge		-	39	-	
Q_{gs}	Gate-Source Charge	V _{DS} =15V, V _{GS} =10V,	-	7.6	-	nC
Q_{gd}	Gate-Drain Charge	ID=TOA	-	7.2	-	
t _{d(on)}	Turn-On Delay Time		-	7.8	-	
t _r	Turn-On Rise Time	V _{DS} =15V, V _{GS} =10V,	-	15	-	
t _{d(off)}	Turn-Off Delay Time	rn-Off Delay Time Rg=3.3Ω, I _D =10A		37	-	ns
t _f	Turn-Off Fall Time		- 1	11	-	



Typical Performance Characteristics

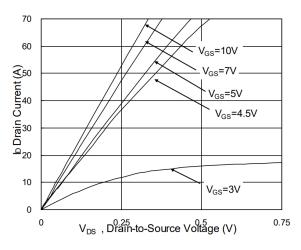


Figure 1. Typical Output Characteristics

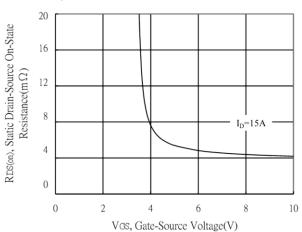


Figure 3. Drain-Source On-State Resistance vs Gate-Source Voltage

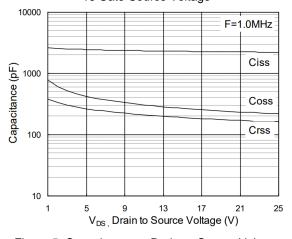


Figure 5. Capacitance vs Drain-to-Source Voltage

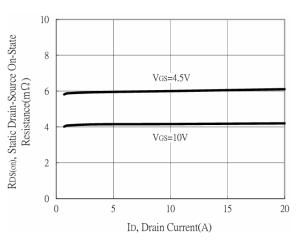


Figure 2. Drain-Source On-State resistance vs Drain Current

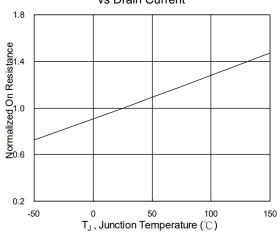


Figure 4. Drain-Source On-State Resistance vs Junction Temperature

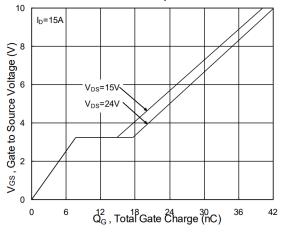


Figure 6. Gate Charge

Typical Performance Characteristics

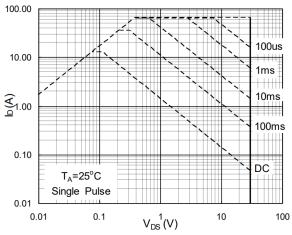


Figure 7. Maximum Safe Operating Area

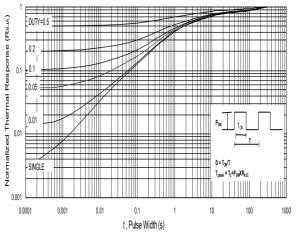


Figure 8. Normalized Transient Thermal Resistance

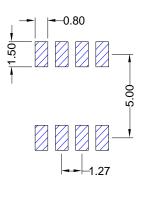


SOP-8

Package Dimension

GAUGE PLANE

Recommended Land Pattern



	Dimensions				
Or made al	Millimeters		Inches		
Symbol	MIN	MAX	MIN	MAX	
Α	-	1.75	-	0.069	
A 1	0.10	0.25	0.004	0.010	
A2	1.25	-	0.049	-	
b	0.31	0.51	0.012	0.020	
С	0.10	0.25	0.004	0.010	
D	4.70	5.10	0.185	0.201	
E	5.80	6.20	0.228	0.244	
E1	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
L	0.4	1.27	0.016	0.050	
θ	0°	8°	0°	8°	

NOTE:

DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END.



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